03500.017504

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:			T
MITSUTOSHI HASEGAWA ET AL			Examiner: Not Yet Assigned
Application No.: 10/647,287			Group Art Unit: Not Yet Assigned
Filed: August 26, 2003)	
For:	ENVELOPE, ENVELOPE MANUFACTURING METHOD, IMAGE DISPLAY DEVICE, AND TELEVISION DISPLAY DEVICE	· ; ;	January 13, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. In accordance with OG Notice August 5, 2003, Applicants waive the requirement under 37 CFR 1.98 for submitting a copy of each cited U.S. patent and each U.S. patent application publication, since the present application was filed after June 30, 2003. However, if the Examiner wishes Applicants to supply any such copies, Applicants will gladly do so upon request.

For the concise explanation of relevance for non-English document, 7-326311, the Examiner is respectfully referred to the English Abstract attached thereto;

for the concise statement of relevance for non-English document 8-185818, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent Nos. 6,137,218 and 6,283,813;

for the concise statement of relevance for non-English document 9-50757, the Examiner is respectfully referred to the English Abstract attached thereto;

for the concise statement of relevance for non-English document 9-102271, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent 6,296,896;

for the concise statement of relevance for non-English document 2000-251665, the Examiner is respectfully referred to the English Abstract attached thereto;

for the concise statement of relevance for non-English document 64-031332, the Examiner is respectfully referred to the English Abstract attached thereto, and to the present application at pages 1-2;

for the concise statement of relevance for non-English document 6-342636, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent Nos. 5,455,597 and 5,659,329;

for the concise statement of relevance for non-English document 11-135018, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent Nos. 6,254,449 and 6,506,089; and

for the concise statement of relevance for non-English document 2001-210258, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent Application Publication 2002-0180342.

The Examiner's attention is also directed to the following U.S. Applications:

APPLICATION NO.	FILING DATE	GROUP ART UNIT
10/624,637 09/647,953	07/23/03 10/06/00	n/y/a 1762
09/705,957	11/06/00	2882

A copy of each cited Application is enclosed.

CONCLUSION

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

Attorney for Applicants

Registration No.

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49 (modified) ATTY DOCKET NO APPLICATION NO. 03500.017504 10/647,287 .S. DEPARTMENT OF COMMERCE TENT AND TRADEMARK OFFICE **APPLICANTS** OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) MITSUTOSHI HASEGAWA ET AL. FILING DATE GROUP August 26, 2003 n/y/a PADER U.S. PATENT DOCUMENTS *EXAMINER DOCUMENT FILING DATE IF APPROPRIATE NUMBER DATE NAME CLASS SUBCLASS 6,060,113 05/00 Banno et al. 427 125 6,296,896 B1 10/01 Takahashi et al. 427 77 2003/0067263 A1 04/03 Tokioka et al. 313 493 08/28/02 6,624,586 B2 09/03 Abe et al. 315 169.1 5,455,597 10/95 Nakamura et al. 345 75 08/97 5,659,329 Yamanobe et al. 345 74 6,137,218 10/00 Kaneko et al. 313 495 FOREIGN PATENT DOCUMENTS TRANSLATION YES/NO/ DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS OR ABSTRACT JP 7-326311 12/95 Japan **Abstract** JP 07/96 8-185818 Japan Abstract JP 9-50757 02/97 Japan **Abstract** JP 9-102271 04/97 Japan **Abstract** JP 2000-251665 9/00 Japan Abstract OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.) M. Hartwell et al, "Strong electron emission from patterned tin-indium oxide thin films", International Electron Devices Meeting 1975, Washington, D.C., Catalog No. 75, CH1023-1, IEDM Technical Digest, pp. 519-521.

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

DATE CONSIDERED

EXAMINER

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO. 03500.017504	APPLICATION NO.	,					
ATENT AND TRADEMARK OFFICE			APPLICANT MITSUTOSHI HASEGAWA ET AL.							
\$ \(\frac{1}{200}\) \(\frac{8}{2}\)			FILING DATE August 26,	2003	GROUP n/y/a					
To all	8		U.S. F	PATENT DOCUMENTS						
-EXAMPLE INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE			
		6,254,449 B1	07/01	Nakanishi et al.	445	25	08/98			
		6,283,813 B1	09/01	Kaneko et al.	445	24				
		2002/0180342 A1	12/02	Yamada et al.	313	493	07/02			
		6,506,089 B2	01/03	Nakanishi et al.	445	25	02/01			
		2003/0058192 A1	03/03	Arai et al.	345	59	09/02			
-										
			FOREIG	N PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT			
	JP	64-31332	2/89	Japan			Abstract			
	JP	6-342636	12/94	Japan		-	Abstract			
	JP	11-135018	05/99	Japan			Abstract			
	JPP	2001-210258	8/01	Japan			Abstract			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)										
EXAMINER DATE CONSI										

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